

# Collective effects in the CLIC damping rings and transfer line

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\* thanks to the SPSU Working Team

- Introduction and damping Rings parameters
- **Electron cloud** in the CLIC **Positron ring**
  - Simulations
  - Technical solutions under investigation
- Overview on other **collective effects**
  - Space charge
  - Single bunch instability thresholds
  - Fast ion instability (**electron ring**)
  - Resistive wall coupled bunch instabilities
- Fast ion simulations in the transfer line
- Conclusions

Updated list of parameters → last column

# Damping rings' parameter evolution

■ At injection:

- $(\epsilon_x, \epsilon_y) = (60, 1.5) \mu\text{m}$
- $\sigma_s = 10\text{mm}$
- $\sigma_\delta = 0.5\%$

■ No impact to output parameters

PARAMETER	2005	2006a	2006b	2007a	2007b
energy [GeV]	2.424				
circumference [m]	360	365.2			
bunch population [E+09]	2.56+5%			5.20+5%	4.00+5%
bunch spacing [ns]	0.533			0.667	
number of bunches/train	110			31	
number of trains	4			1	
store time/train [ms]	13.3			20	
rms bunch length [mm]	1.55	1.51	1.59	1.49	1.53
rms momentum spread [%]	0.126	0.136	0.130	0.138	0.135
hor. normalized emittance [nm]	540	380	308	443	386
ver. normalized emittance [nm]	3.4	2.4	3.9	4.3	4.1
lon. normalized emittance [eV.m]	4725	5000	4982	4998	4993
(horizontal, vertical) tunes	(69.82, 34.86)	(69.82, 33.80)			
coupling [%]	0.6		0.13		
ver. dispersion invariant [ $\mu\text{m}$ ]	0		0.248		
wiggler field [T]	1.7	2.5			
wiggler period [cm]	10	5			
energy loss/turn [MeV]	2.074	3.903			
hor./ver./lon./ damping times [ms]	2.8/2.8/1.4	1.5/1.5/0.75			
RF Voltage [MV]	2.39	4.25	4.185	4.345	4.280
number of RF cycles	2			1	
repetition rate [Hz]	150			50	
RF frequency [GHz]	1.875			1.499	

From Y. Papaphilippou, in CLIC-Parameter-WG

## More parameters needed for the collective effects (I)

Description	Unit	Value
Average $\beta_x$ dipoles	m	0.5
Average $\beta_y$ dipoles	m	0.5
Average $\beta_x$ wigglers	m	4.0
Average $\beta_y$ wigglers	m	4.0
Number of bends		96
Dipole length	m	0.545
Number of wigglers		76
Wiggler length	m	2
Momentum compaction $\alpha$		$8.02 \times 10^{-5}$
Hor. chromaticity $Q'_x$		2.03
Vert. chromaticity $Q'_y$		-0.24

*From the present DR design, thanks to Y. Papaphilippou*

⇒ Average beta functions together with the emittances define the **average bunch transverse sizes** over the arcs and the wigglers

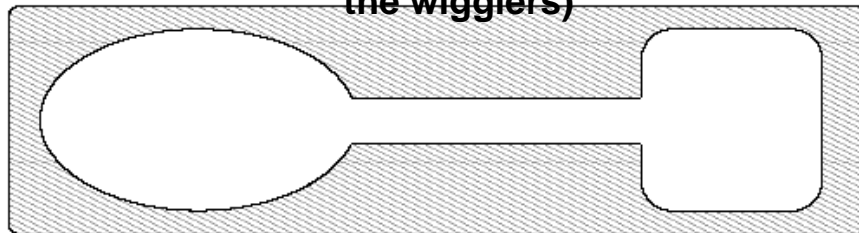
⇒ Number and length of dipoles and wigglers define the fraction of the ring covered by those elements and therefore a **scaling factor for the e-cloud density** to be used in instability simulations

## More parameters needed for the collective effects (II)

Vacuum chamber dimensions	CLIC DR	
	Arc	Wiggler
horizontal semi axis /mm	22	16
vertical semi axis /mm	18	9
antechamber-slot half height		3
chamber area /cm <sup>2</sup>	12.4	5.8

*D. Schulte, R. Wanzenberg, F. Zimmermann, in Proceed. ELOUD'04*

**Design of the vacuum chamber with antechamber in the arcs (it has double sided ante-chamber in the wigglers)**



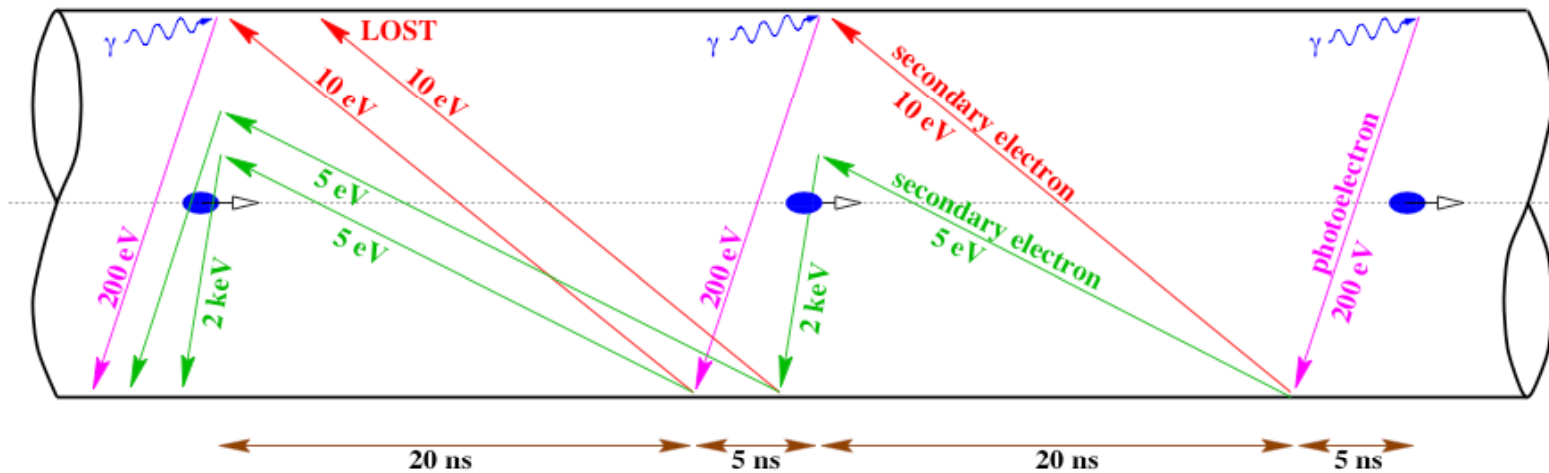
The antechamber absorbs 90 to 99.9% of the synchrotron radiation and gives a photoemission yield in the main chamber 10 to 1000 times lower than in a design w/o antechamber

## Photoemission yields

	CLIC DR	
	Arc	Wiggler
$N_0 / 10^{10}$	0.5	0.5
$\rho/m$	8.67	4.58
$dN_\gamma/dz [e^+/m]$	5.764	10.903
$Y_{\text{eff}}$	0.01	0.01
$dN_{e^-}/dz [e^+/m]$	0.0576	0.109
$dN_{e^-}/dz^{\text{ion}} [e^+/m]$	$4 \times 10^{-8}$	$4 \times 10^{-8}$

## Electron cloud build up: a multi-bunch process...

$$\frac{h_y^2}{N_b r_e L_{sep}} = 1$$



### Principle of the multi-bunch multipacting.

⇒ Electrons can be generated via photoemission, rest gas ionization or beam loss at the chamber walls. They then multiply due to the secondary emission process

## Effects of the electron cloud on the beam:

### Tune shift

The tune increases along a train of positively charged particle bunches because the bunches at the tail of the train feel the strong focusing effect of the electron cloud formed by the previous bunches.

### Electron cloud instability in rings

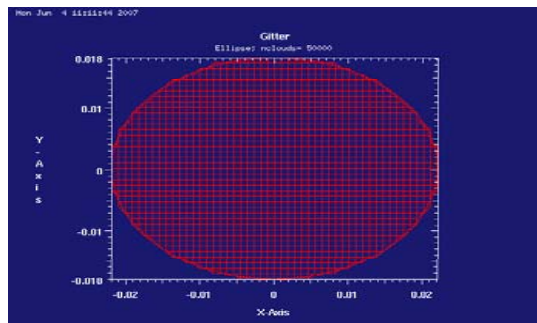
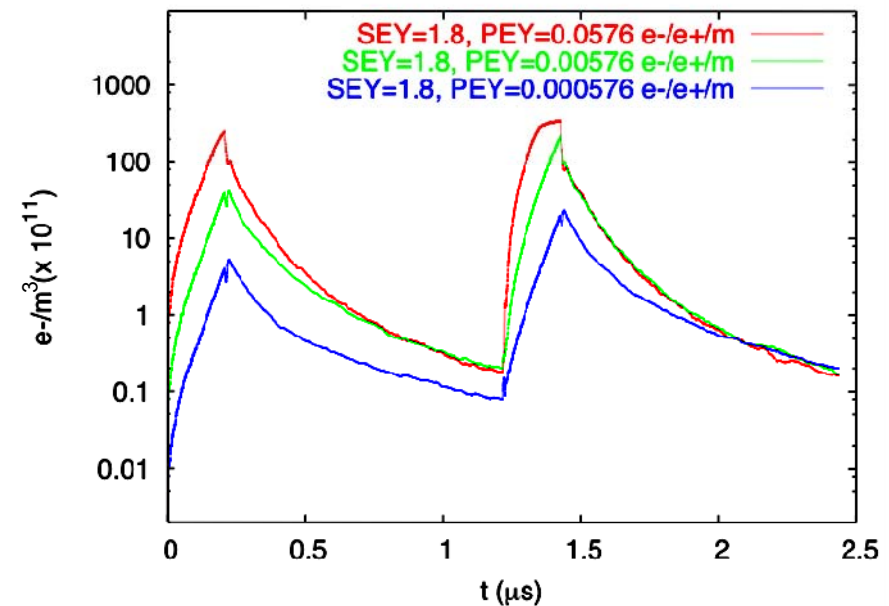
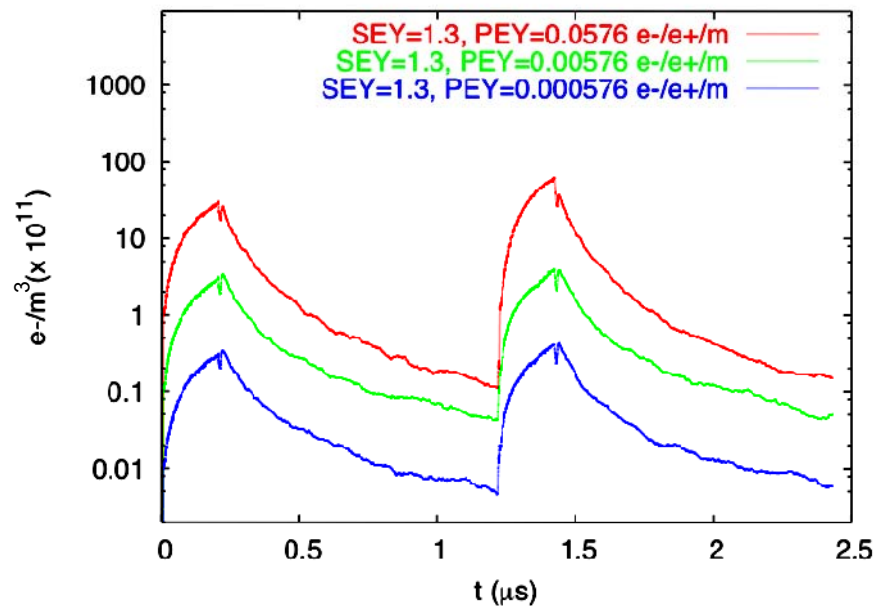
⇒ **Coupled bunch phenomenon**: the motion of subsequent bunches is coupled through the electron cloud and the amplitude of the centroid motion can grow.

⇒ **Single bunch phenomenon**: the motion of head and tail of a single bunch can be coupled through an electron cloud and give rise to an instability

Tune shift along the train as well as instabilities affecting only the last bunches of long trains have been observed in several machines (SPS, KEKB-LER, CEsr-TA), clearly pointing to the electron cloud as source of these phenomena.

# Electron cloud build up in the arcs (simulations with Faktor2)

Central electron density in a radius of  $5\sigma_x \times 5\sigma_y$

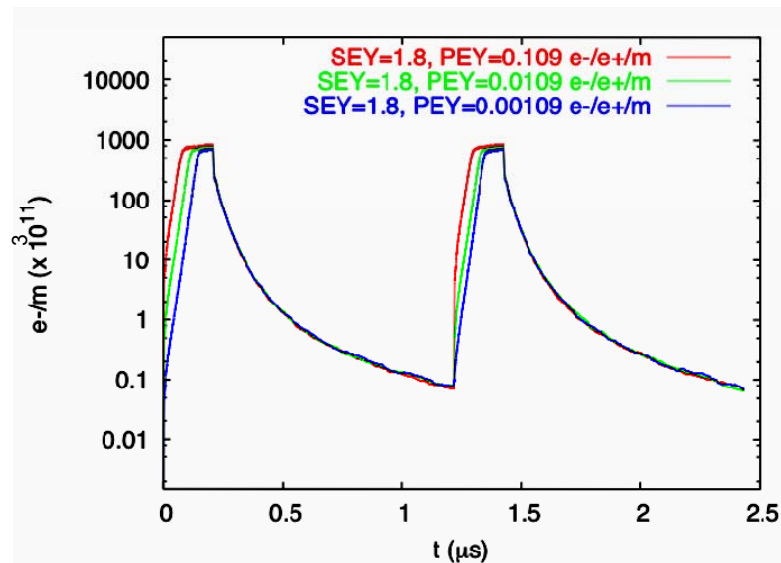
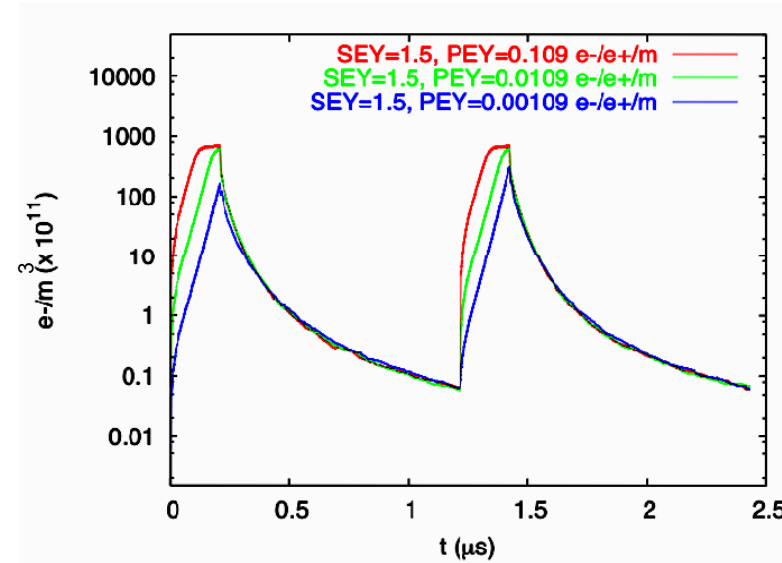
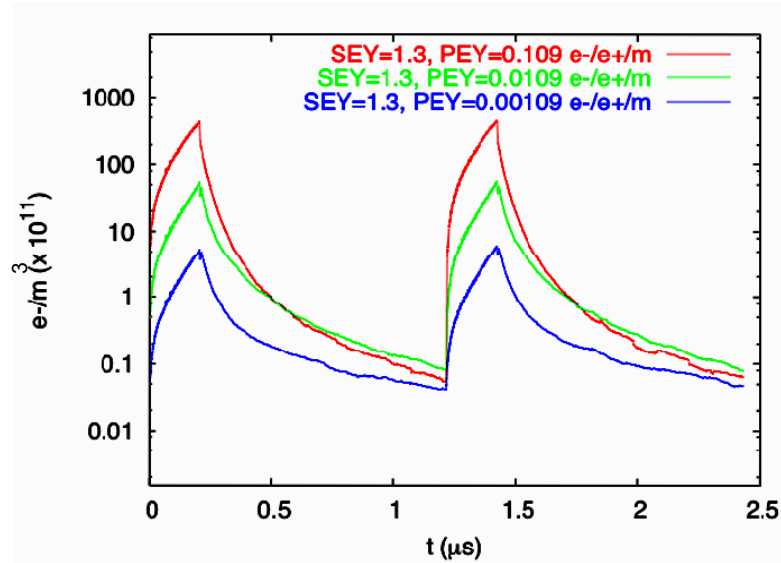


→ Low maximum SEY does not cause high density electron cloud build up

→ High maximum SEY causes exponential rise, which can saturate over few turns if the PEY is also sufficiently high

# Electron cloud build up in the wigglers (simulations with Faktor2)

## Central densities for different PEYs and SEYs



→ The electron cloud in the wigglers can have high density values if

- ✓ The PEY is high enough (i.e., more than 0.01% of the produced radiation is not absorbed by an antechamber or by special absorbers), even if the SEY is low
- ✓ The SEY is above 1.3, independently of the PEY



## Summary of the density values obtained from build up simulations

	PEY	SEY	$10^{12} \text{ e}^-/\text{m}^3$
Dipole chamber	0.000576	1.3	0.04
	0.000576	1.8	2
	0.0576	1.3	7
	0.0576	1.8	40
Wiggler chamber	0.00109	1.3	0.6
	0.109	1.3	45
	0.109	1.5	70
	0.109	1.8	80

For these values there is basically a negligible electron cloud

Here the values do not change even with a lower PEY

To model an integrated effect over one turn, these values have to be scaled by:

- **Wigglers**  $\Rightarrow$  (total wiggler length)/circumference =  $(76 \times 2)/365 = \mathbf{0.41}$
- **Arcs**  $\Rightarrow$  (total arc length)/circumference =  $(96 \times 0.545)/365 = \mathbf{0.143}$

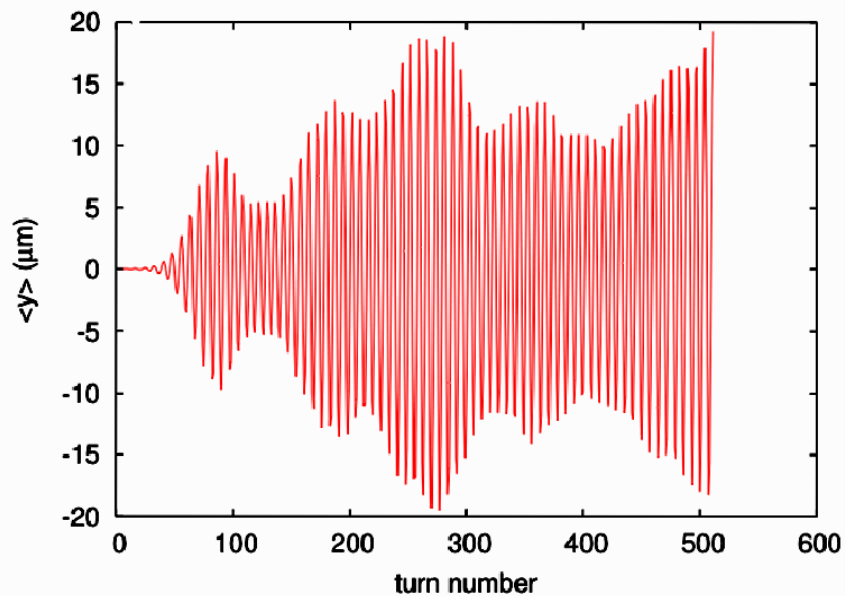
## Instability simulations to check beam stability (simulations done with HEADTAIL)

→ In case of electron cloud build up, we assume these density values in arcs and wigglers:

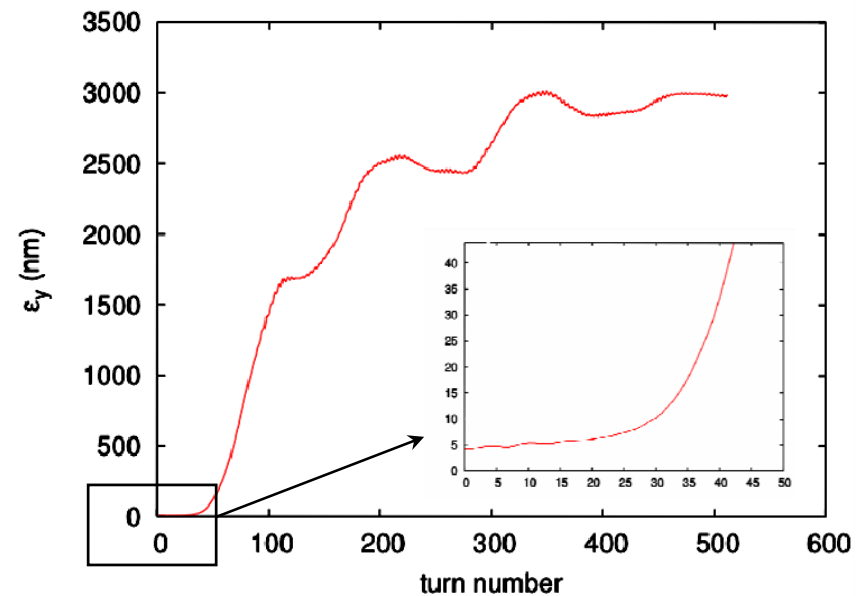
$$\rho_{\text{wig}} = 1.8 \times 10^{13} \text{ m}^{-3}$$

$$\rho_{\text{dip}} = 3 \times 10^{11} \text{ m}^{-3}$$

→ The beam is strongly unstable



\* Vertical centroid motion



\* Vertical emittance evolution

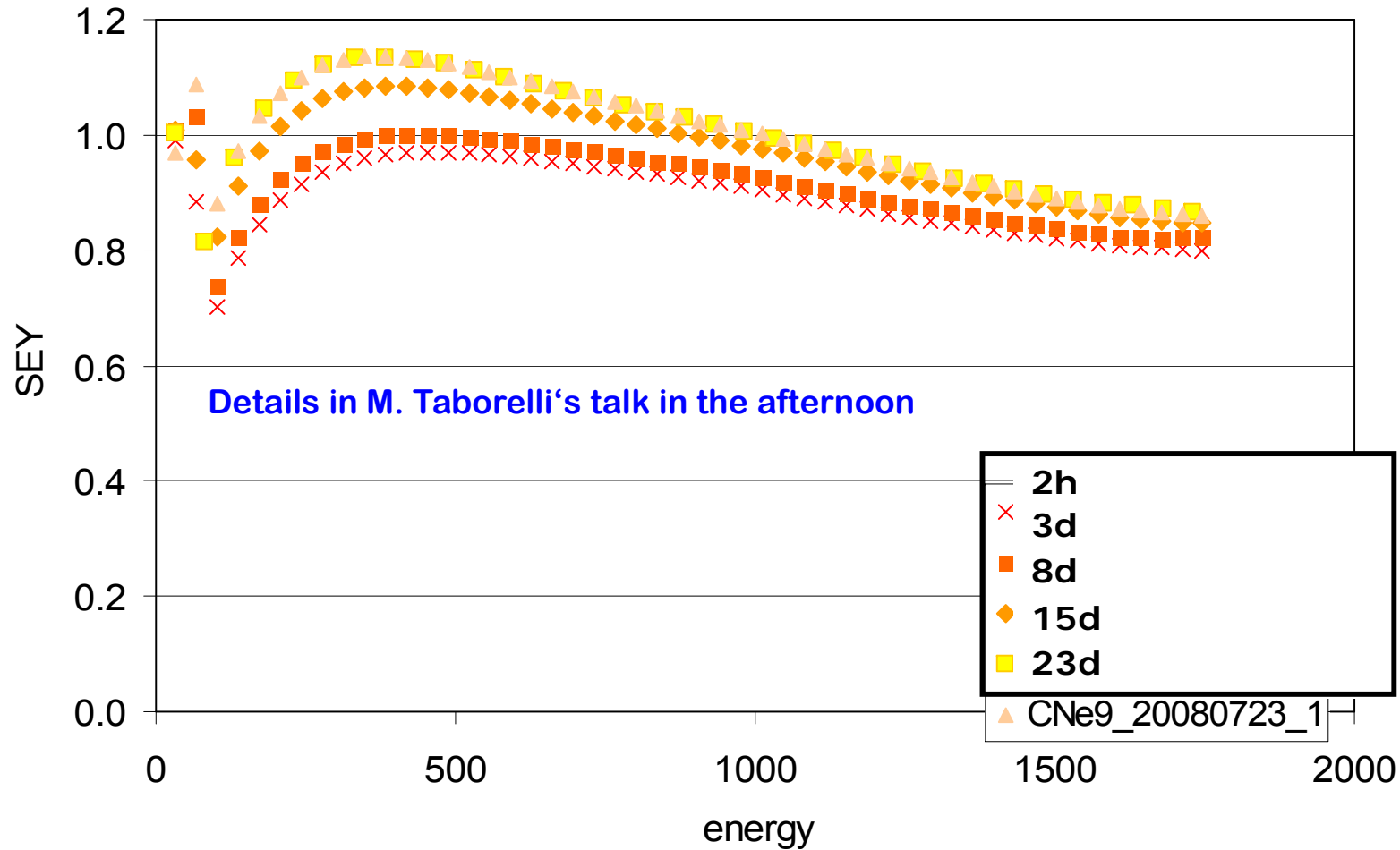
## Against the electron cloud.....

- If there is electron cloud in the CLIC-DR, the beam becomes unstable!
  - o Conventional feedback systems cannot damp this instability (wider band needed)
  - o It is necessary to find techniques against the formation of the electron cloud
  
- Several mitigation techniques are presently under study:
  - ✓ Low impedance clearing electrodes
  - ✓ Solenoids (KEKB, RHIC) -however only usable in field free regions!
  - ✓ Low SEY surfaces
    - Grooved surfaces (SLAC)
    - NEG coating
    - ~~New coatings~~ presently under investigation (SPS)

Carbon coatings, studied by the SPS Upgrade Working Team, seem very promising and a possible solution.... (M. Taborelli's talk this afternoon)

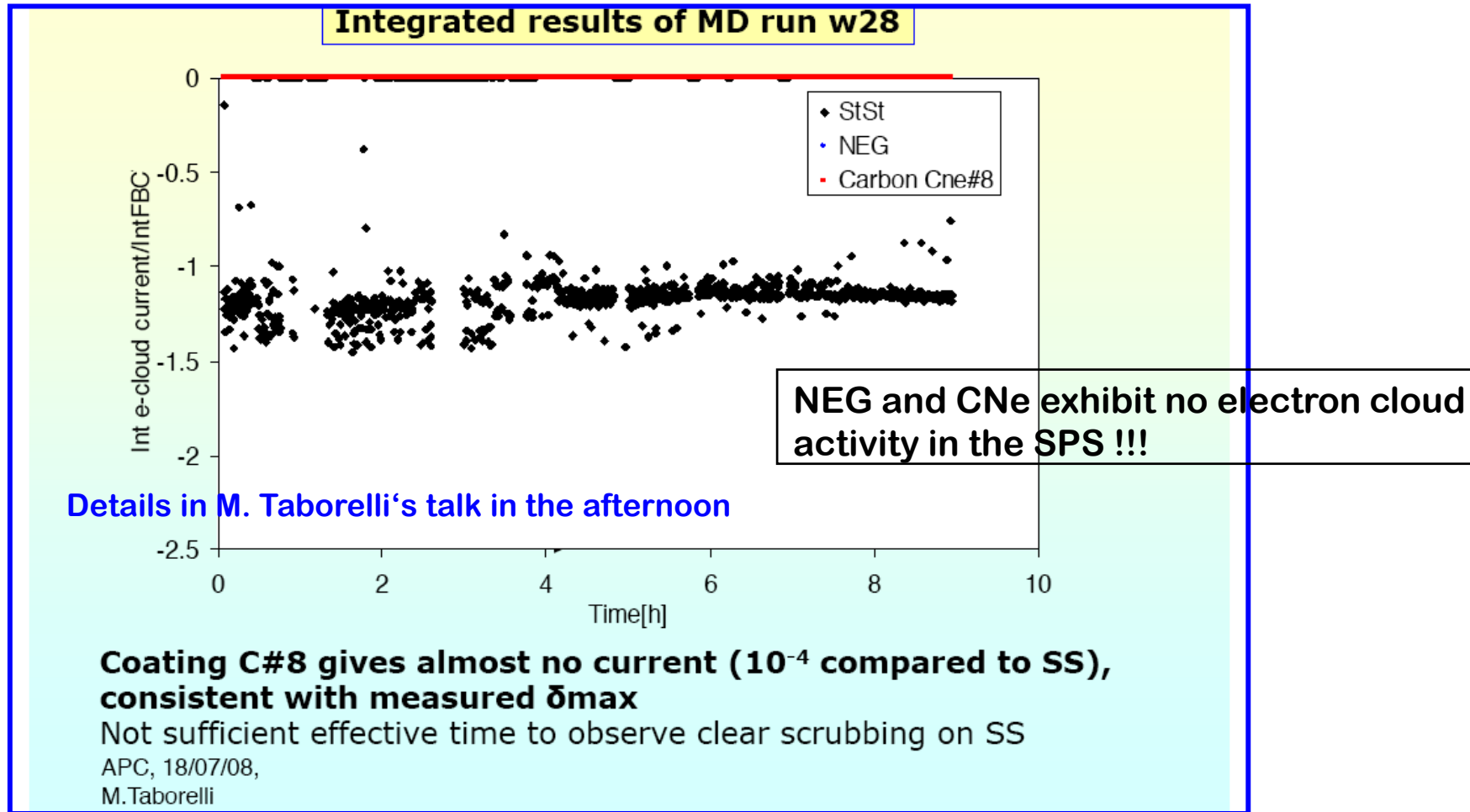
# SEY of CNe

Courtesy M. Taborelli from SPSU-WT



The maximum SEY starts from below 1 and gradually grows to slightly more than 1.1 after 23 days of air exposure. The peak of the SEY moves to lower energy.

## Measurements inside the SPS confirm the lab measurements!



Perhaps this is the strategy to get rid of electron cloud issues ??...

→ However, need to check the PEY of these coated surfaces in order to fully validate their use for DRs as well!

→ Tests planned at ESRF (maybe also in Cesr-TA)

## SPACE CHARGE (I)

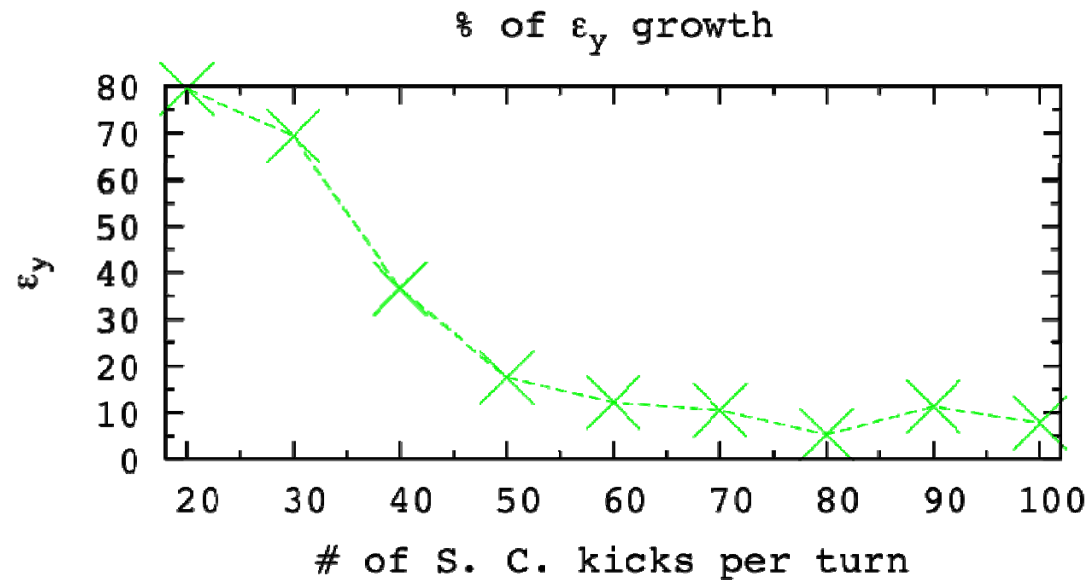
- **Tune spread** induced by space charge can be estimated analytically integrating the space charge induced gradient all around the lattice to take into account of the beam size change due to the betatron modulation
- The horizontal tune spread is in the order of 0.01
- The effect is obviously much stronger in the vertical plane because the beam is smaller in this plane

$$\Delta Q_y = \frac{N_b r_e C}{(2\pi)^{3/2} \gamma^3 \sigma_z} \sqrt{\frac{1}{\epsilon_y}}$$

$$\cdot \left\langle \frac{\sqrt{\beta_y}}{\sqrt{\beta_x \epsilon_x + D_x^2 \sigma_\delta^2 + \beta_y \epsilon_y}} \right\rangle \simeq 0.188$$

## SPACE CHARGE (II)

- **Space charge** can also be responsible for emittance growth
- The effect can be estimated simulating the multi-turn transport of a bunch through the CLIC damping ring applying several space charge kicks randomly selected in the lattice
- The simulations have been carried out with the HEADTAIL code for an increasing number of kicks per turn and running 10 different seeds for each case
- Starting from a number of kicks  $N > 60$ , the value levels off at  $\sim 8-10\%$ , which would still be not acceptable.



# SINGLE BUNCH INSTABILITIES

- **Longitudinal**

- ✓ The Boussard criterion (including in the formula the suppression factor  $(b/\sigma_z)^2$ ) would give a maximum impedance **value of  $\sim 5\Omega$**

$$\left| \frac{Z_0^{\parallel}}{n} \right| < 1.7 \ln(2) Z_0 \frac{|\eta| \gamma}{N_b r_0} \sigma_\delta^2 \sigma_z$$

.

- **Transverse**

- ✓ The TMCI threshold is given by the formula below
- ✓ The CLIC-DRs are in short bunch regime, and the formula translates into a tolerable **impedance value of  $\sim 15 \text{ M}\Omega/\text{m}$**  if  $\omega_r = 2\pi \times 6 \text{ GHz}$

$$\xi < \frac{Q_s}{\omega_r \sigma_t} \quad \text{if } \omega_r \sigma_t \leq 1$$
$$\xi < \sqrt{2} Q Q_s (\omega_r \sigma_t)^2 \quad \text{if } \omega_r \sigma_t \gg 1$$

where

$$\xi = \frac{\omega_r / 2\pi \langle \beta_y \rangle R_T N_b e}{3.75 Q E / e}$$



# COUPLED BUNCH INSTABILITY FROM RESISTIVE WALL

- Transverse

$$\Delta\omega_{\mu,m}^{x,y} = -\frac{i}{2} \frac{\Gamma(m+1/2) N_b r_0 c^2 \langle\beta_{x,y}\rangle}{2^m m! \gamma C \sigma_z}$$

$$\frac{\sum_{p=-\infty}^{\infty} Z_1^{x,y}(\omega_p) h_m(\omega_p - \omega_{\xi x,y})}{\sum_{p=-\infty}^{\infty} h_m(\omega_p - \omega_{\xi x,y})},$$

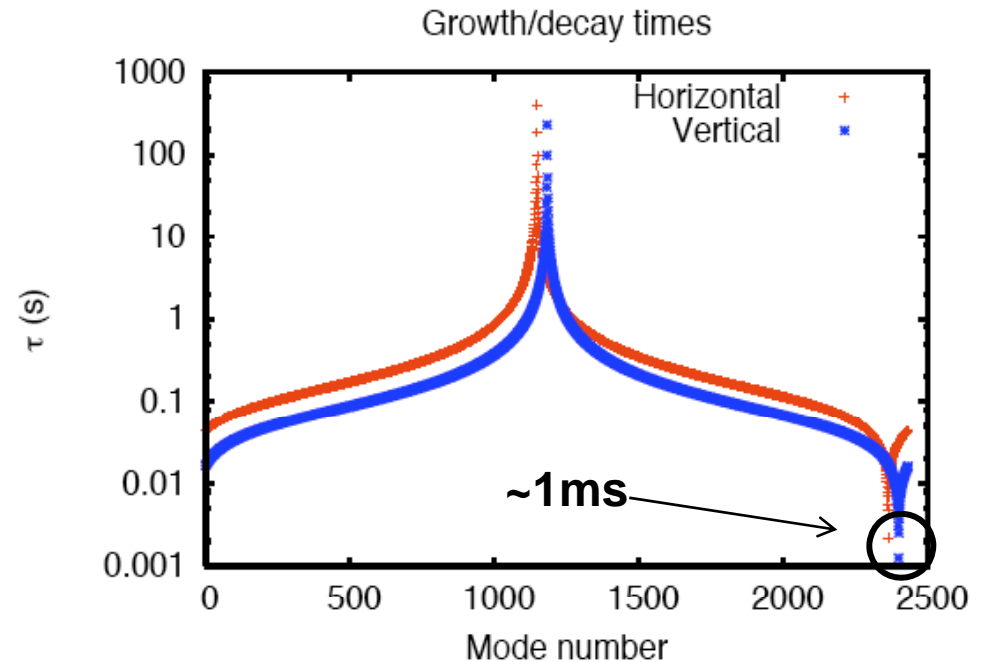
with

$$h_m(\omega) = \left(\frac{\omega \sigma_z}{c}\right)^{2m} \exp\left(-\frac{\omega^2 \sigma_z^2}{c^2}\right)$$

$$\omega_p = (pM + \mu + Q_{x,y} + m\nu_s)\omega_0$$

$$\mu = 0, 1, \dots, M-1$$

$$m = 0, \pm 1, \pm 2, \dots$$



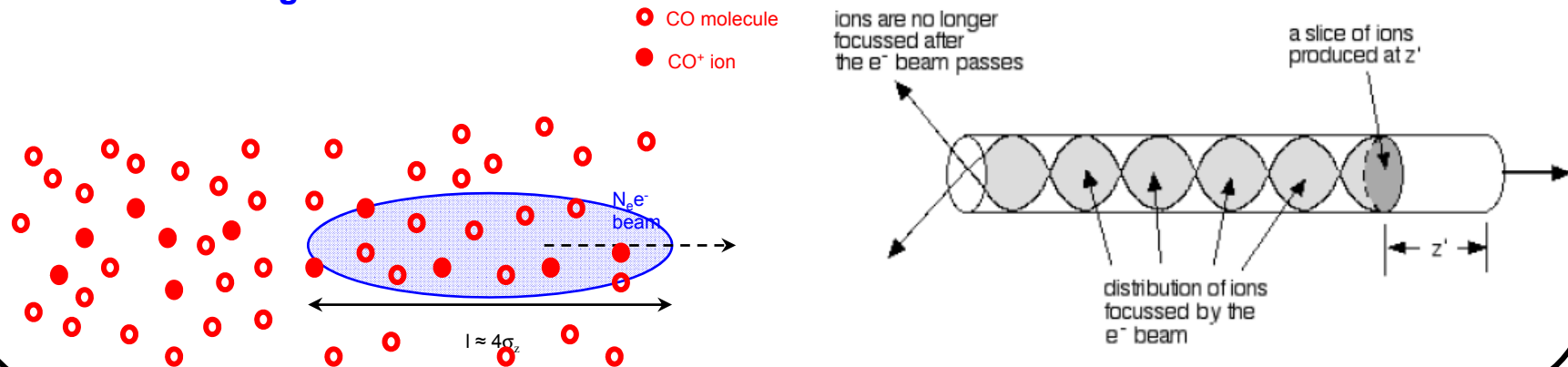
Pessimistic estimate because:

- wigglers only cover half of the ring, which gives possibly a factor 2
- instability rate has to be scaled by  $n_b/M$ , because the formulae assume a uniformly filled ring.

# FAST ION (I)

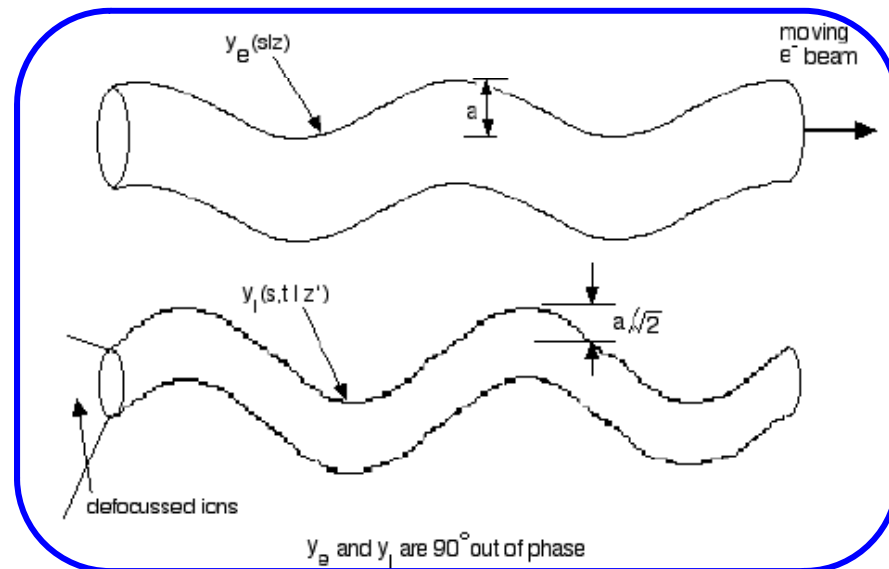
The ions produced by gas ionization can be focused by the electric field of the following bunches and they accumulate in the vicinity of the beam (trapping condition)

Ions: residual gas ionization



The ion cloud can affect the motion of the bunches and an unstable ion-electron coupled motion can be excited

Two-stream instability



## FAST ION (II)

The ions trapped around the beam are those having a mass number above:

$$A_{crit} = \frac{N_b \Delta T_b c r_p}{2 \sigma_y (\sigma_x + \sigma_y)} \simeq 13$$

This means that molecules like N<sub>2</sub>, CO, H<sub>2</sub>O are trapped around the beam

Trapped ions cause tune spread (p=1 nTorr)

$$\Delta Q_{ion} \simeq \frac{N_b n_b r_e C}{\pi \gamma \sqrt{\epsilon_x \epsilon_y}} \left( \frac{\sigma_{ion} p}{k_B T} \right) \simeq 0.05$$

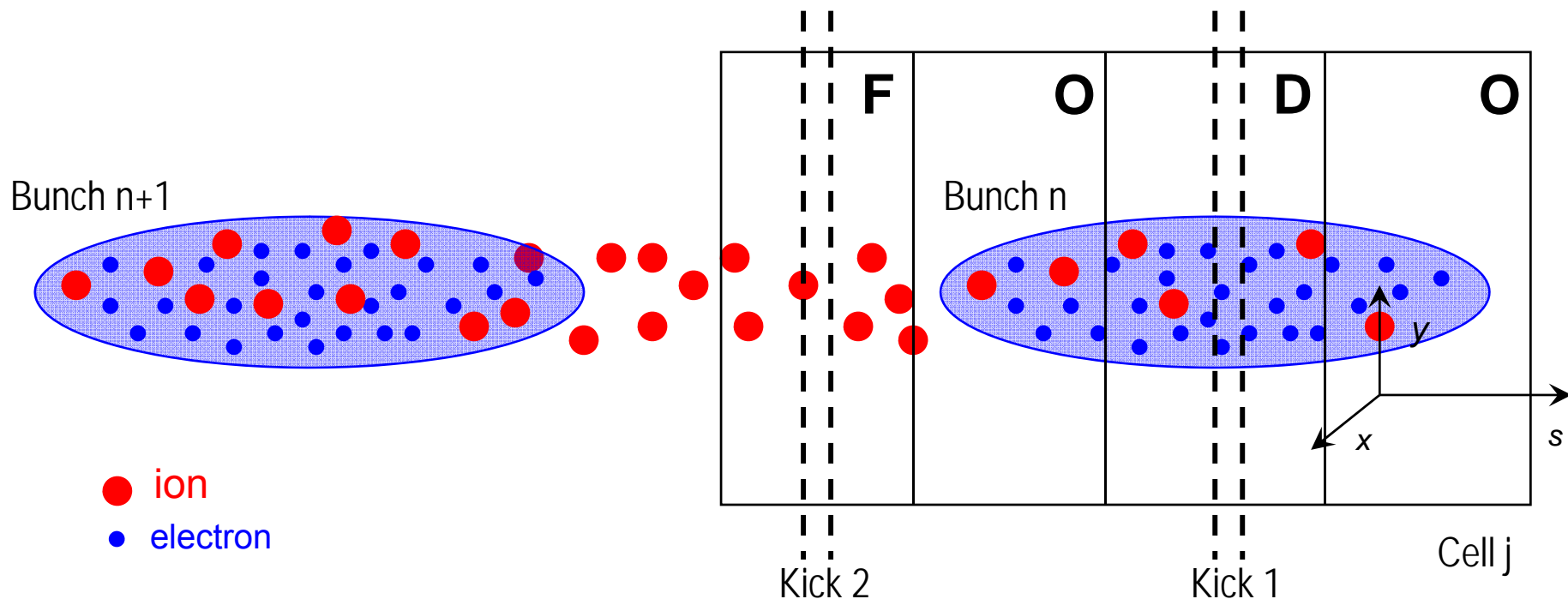
and a fast instability having a rise time of about 1.1 μs, calculated with the following formula.

$$\tau_{inst} \simeq \frac{0.1 \cdot \gamma \sigma_x \sigma_y}{N_b n_b c r_e \beta_y \sigma_{ion}} \left( \frac{k_B T}{p} \right) \sqrt{\frac{8}{\pi}}$$

# FAST ION IN THE TRANSFER LINE

To study the fast ion instability in a transport line, we have developed **FASTION**

- **Multi-bunch** code, ions and electrons are macro-particles
- Ions of an **arbitrary number of species** are created at each bunch passage and propagated through the train
- Line is made of **a sequence of FODO cells**, **two kicks** per FODO cell, or the lattice is passed through an external file. Acceleration along the line can be included.
- **Electromagnetic interaction**: the ions are kicked by the passing bunches and the bunch macro-particles feel the effect of the ion field



## Some parameters of the transfer line

⇒ We have carried out simulations of fast ion instability using the following parameters

⇒ Beam energy is 9 GeV. Length is 20 km.

⇒ Residual gas pressure is 1 nTorr for each species. Only two species of ions have been considered (CO and H<sub>2</sub>O)

⇒ Bunch population is  $4 \times 10^9$  ( $3.7 \times 10^9$ )

⇒ Bunch spacing is 500 ps

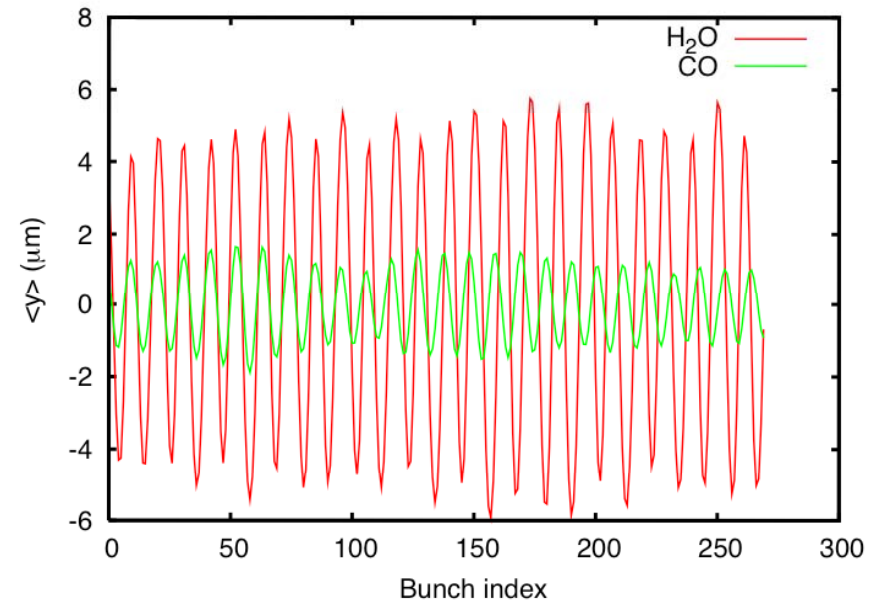
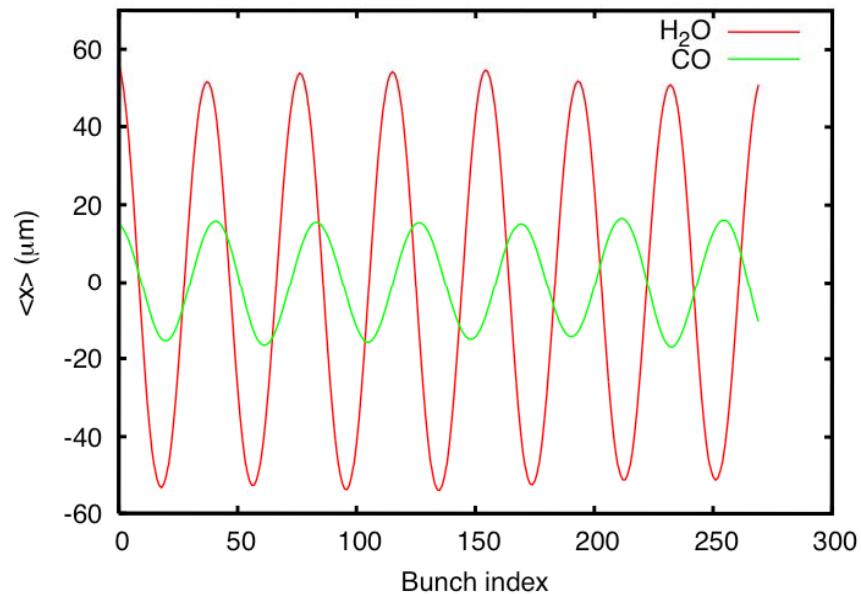
⇒ Number of bunches ( $N_b$ ) is 300

⇒ Normalized emittances are 680,10 nm ( $660,10$ )

⇒ Line is made of 500 FODO cells (each 40m long) with a phase advance of 70°

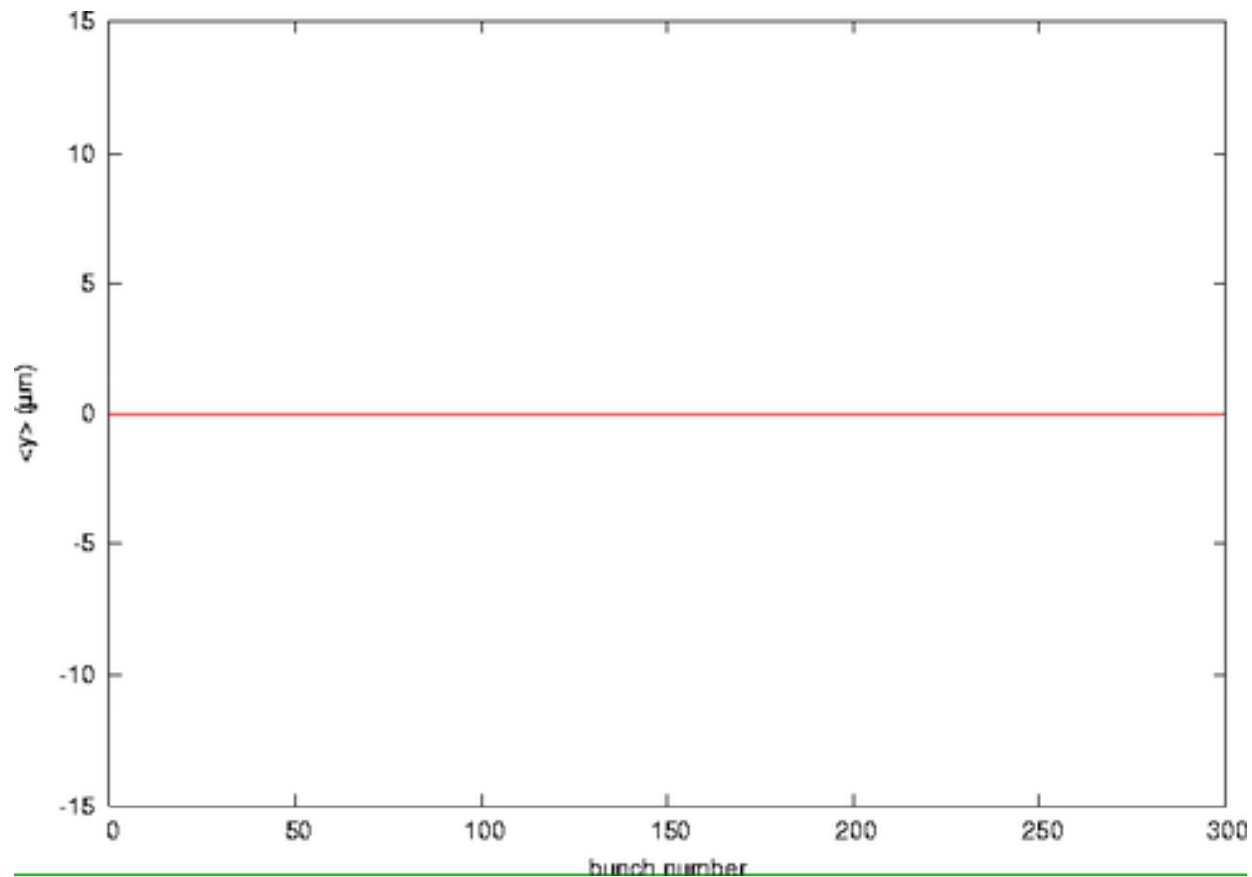
# Trapped ions in the transfer Line

⇒ The motion of two sample ions (of two different species, CO and H<sub>2</sub>O) show that they are trapped around the beam



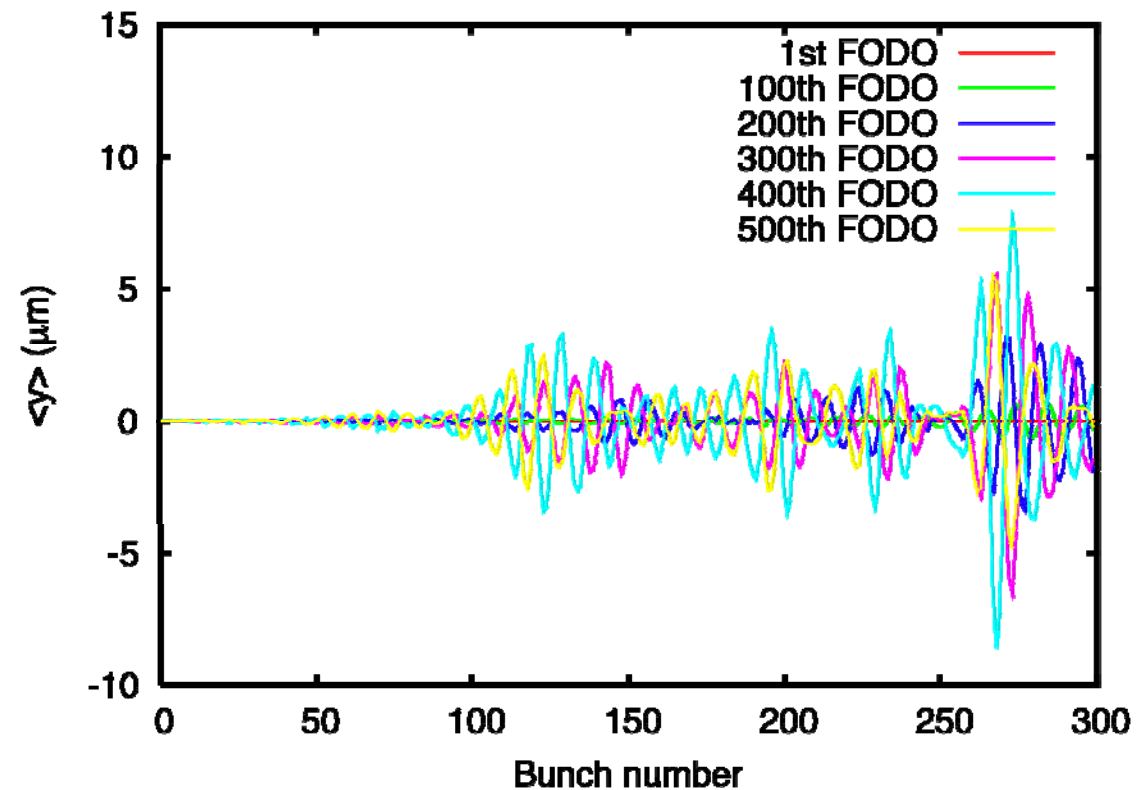
## Instability in the transfer line (movie)

⇒ A coherent instability in the vertical plane develops along the line for a pressure of 1 nTorr



## Instability in the transfer line (snap-shots)

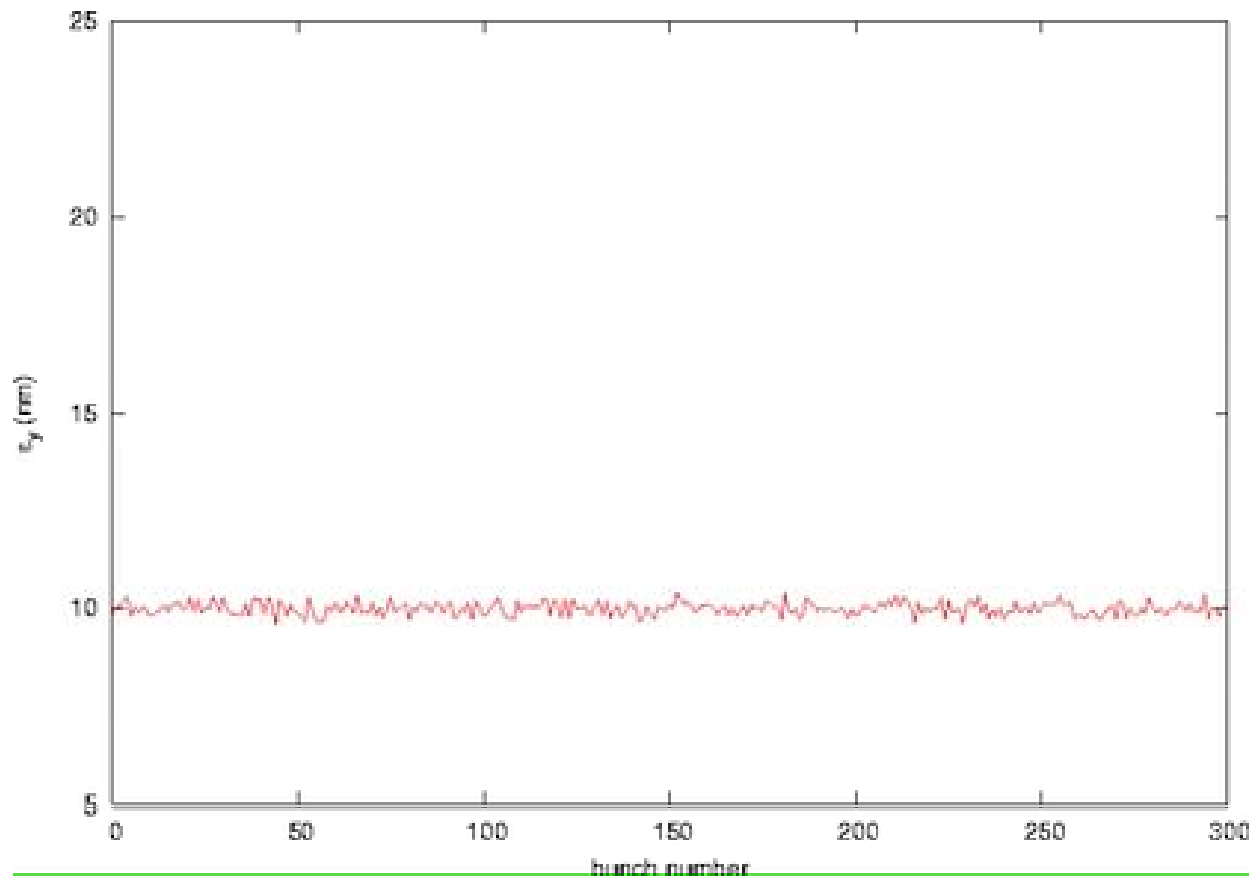
⇒ A coherent instability in the vertical plane develops along the line for a pressure of 1 nTorr





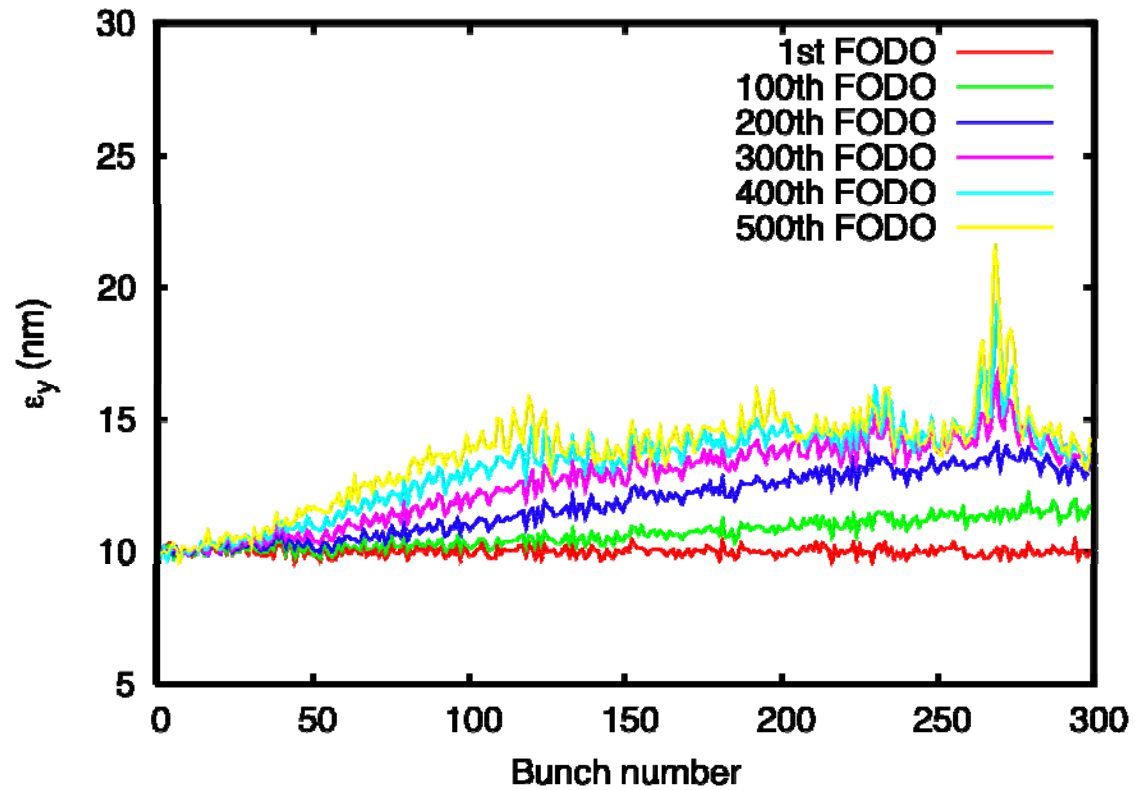
## Emittance growth along the transfer line (movie)

⇒ The instability in the vertical plane also causes emittance growth (p=1 nTorr)



# Emittance growth along the transfer line (snapshots)

⇒ The instability in the vertical plane also causes emittance growth (p=1 nTorr)



# Conclusions (I)

- The electron cloud (build up and instability) in the positron ring poses constraints on PEY and SEY of the beam pipe.
  - Wigglers should be designed such as to be able to absorb **99.9% of the produced synchrotron radiation**
  - The maximum SEY should be kept **below 1.3**
  - Special **chamber coatings** (under study) could be required
- Space charge
  - Causes a very **large tune spread** in the vertical plane (0.188)
  - Simulations show it is responsible for **~10% emittance growth** over the residence time of the beam in the DRs.
- Instabilities (impedances)
  - Single bunch: they can be avoided with a **smooth impedance design**
  - Resistive wall coupled bunch: can be controlled with **feedback**
- Fast ion instability:
  - Molecules with  **$A > 13$**  will be **trapped**
  - Poses a constraint on the acceptable **vacuum pressure** (0.1 nTorr)

# Conclusions (II)

- The ion effects in the transfer line have been studied with the **FASTION** code. The code:
  - models the **generation of ions and their interaction** with a train of bunches going down a transport line
  - can deal with the interaction of the multi-bunch beam with an **arbitrary number** of different types of ions
- Simulations show that
  - **1 nTorr** is enough to have a fast instability in the transfer line, therefore the pressure is required to be 0.1 nTorr also in the transfer line.